IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Toshiaki NAGAI

Serial Number: Not Yet Assigned

Filed: August 27, 2003 Customer No.: 23850

For: MEASURING DEVICE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

August 27, 2003

Sir:

In compliance with 37 CFR 1.56, Applicant calls to the attention of the Patent and Trademark

Office the references listed on the attached PTO-1449.

A copy of each of the references, except for the U.S. references, is enclosed herewith.

In the event there are any fees due in connection with the filing of this paper, please charge Deposit Account No. <u>01-2340</u>.

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Enclosures: PTO-1449; References (9)

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INFORMATION DISCLOSURE STATEMENT PTO-1449

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Applicant(s): Toshiaki NAGAI

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U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
	AA	5,004,307	Kino et al.	04/02/91			
	AB	5,939,709	Ghislain et al.	08/17/99			
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	AK	W.W. Clegg et al.; Journal of Magnetism and Magnetic Materials, Vol. 95, pp.49-57, 1991.		
	AL	R.J.M. van de Veerdonk et al.; Journal of Magnetism and Magnetic Material, Vol. 235, pp.138-142, 2001.		
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PRIOR ART INFORMATION LIST

Your case No.	
Our case No.	F1101P-US

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Inventor, Patent Number, Country Author, Title, Name of Document	Issue Date	Concise Explanation of the Relevance (indication of page, column, line, figure of the relevant portion)
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